

<b>Notice of References Cited</b>	Application/Control No. 10/088,917	Applicant(s)/Patent Under Reexamination MURAKAMI ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

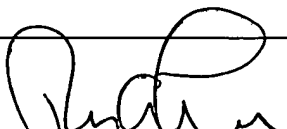

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0008997 A1	01-2003	Murakami et al.	526/348
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 264 848 A1	12-2002	Europe	Murakami et al.	C08F 210/02
	O	JP 11-106429 A	04-1999	Japan	---	C08F 10/02
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	 

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.